#### AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions, and listings, of claims in the current application.

### LISTING OF THE CLAIMS

- 1. (Cancelled).
- 2. (Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein incident light is collected in a center of a plane made of said plurality of lighttransmitting films, the incident light being incident at an angle asymmetrical to a center of a plane made of said plurality of light-transmitting films.

(Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein an amount of phase change of the incident light,  $\phi(x)$ , depends on a distance x in an in-plane direction and approximately satisfies the following equation,

$$\phi(x) = Ax^2 + Bx\sin\theta + 2m\pi$$

wherein  $\theta$  is an incident angle of the incident light, A and B are predetermined constants, and m is a natural number.

 (Previously Presented) The solid-state imaging apparatus according to claim 9, wherein

$$\Delta n(x) = \Delta n_{\text{max}} [\phi(x)/2\pi + C]$$

is satisfied, where  $\Delta n_{\text{max}}$  is a difference of refractive indices between one of said plurality of light-transmitting films and a light-incoming side medium,  $\Delta n(x)$  is a difference of refractive

indices between another one of said plurality of light-transmitting films and the light-incoming side medium at a position x, and C is a constant.

- 5. (Currently Amended) The solid-state imaging apparatus according to claim 9,
- wherein heights of said plurality of light-transmitting films are constant in a direction normal to said plurality of light-transmitting films.
- (Previously Presented) The solid-state imaging apparatus according to claim 9,
  wherein each of said plurality of light-transmitting films includes one of TiO<sub>2</sub>, ZrO<sub>2</sub>,
  Nb<sub>2</sub>O<sub>5</sub>, Ta<sub>2</sub>O<sub>5</sub>, Si<sub>3</sub>N<sub>4</sub> and Si<sub>2</sub>N<sub>3</sub>.
- 7. (Previously Presented) The solid-state imaging apparatus according to claim 9, wherein each of said plurality of light-transmitting films includes one of SiO<sub>2</sub> doped with B or P, that is Boro-Phospho Silicated Glass, and Teraethoxy Silane.
- (Previously Presented) The solid-state imaging apparatus according to claim 9,
   wherein each of said plurality of light-transmitting films includes one of benzocyclobutene, polymethymethacrylate, polyamide and polyimide.
- (Currently Amended) A solid-state imaging apparatus comprising arranged unit pixels, each
  of which includes a light-collector and a light-receiver,

wherein said light-collector comprises:

a substrate into which incident light is incident; and

above said substrate, a plurality of light-transmitting films are formed in a region into which the incident light is incident,

wherein a light-transmitting film of said plurality of light-transmitting films forms zones; in which a width of each zone a zone having a width which is equal to or shorter than a wavelength of the incident light,

wherein each zone shares a center point which is located at a position displaced from a center of said light-receiver, and

said plurality of light-transmitting films form an effective refractive index distribution,

wherein, in a unit pixel, among said unit pixels, which is located at a center of a plane on which said unit pixels are formed, a position at which an effective refractive distribution of a corresponding light-collector is a maximum value matches a central axis of a corresponding light-receiver, and

wherein in a unit pixel, among said unit pixels, which is located at a periphery of the plane, a position at which the effective refractive distribution of a corresponding light-collector is a maximum value is displaced from the central axis of a corresponding light-receiver toward the center of the plane.

10. (Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein an off-centered light-transmitting film is formed in an area shared by one lightcollector and another light-collector in an adjacent unit pixel.

(Previously Presented) The solid-state imaging apparatus according to claim 9, comprising:
 a first unit pixel for a first color light out of the incident light; and

a second unit pixel for a second color light which has a typical wavelength that is different from a typical wavelength of the first color light;

wherein said first unit pixel includes a first light-collector, and

said second unit pixel includes a second light-collector, in which a focal length of the second color light is equal to a focal length of the first color light in said first light-collector.

12. (Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein a focal point is set at a predetermined position by controlling an effective refractive index distribution of said light-transmitting film.

13. (Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein each of said unit pixels further includes a light-collecting lens on a lightoutgoing side of said light-collector.

14. (Previously Presented) The solid-state imaging apparatus according to claim 9,

wherein an effective refractive index distribution of said light-transmitting film is different between light-collectors of said unit pixels located at the center of said plane on which said unit pixels are formed and light-collectors of said unit pixels located at the periphery of the plane.

- 15. (Cancelled).
- 16. (New) The solid-state imaging apparatus according to claim 9,

wherein each of said plurality of light-transmitting films of one of said unit pixels located near the center of an imaging area has a line width different from a line width of each of said light-transmitting films of one of said unit pixels located at the periphery of the imaging area and is located at a same relative position in said light-collector as a position of each of said light-transmitting films of the one of said unit pixels located near the center of the imaging area, the imaging area being a plane area on which said unit pixels are formed, and

a sum of line widths of said plurality of light-transmitting films of the one of said unit pixels located near the center of the imaging area differs from a sum of line widths of said plurality of light-transmitting films of the one of said unit pixels located at the periphery of the imaging area.

## 17. (New) The solid-state imaging apparatus according to claim 16,

wherein each of said plurality of light-transmitting films of the one of said unit pixels located at the periphery of the imaging area has a line width shorter than a line width of each of said light-transmitting films of the one of said unit pixels located near the center of the imaging area and is located at a same relative position in said light-collector as a position of each of said light-transmitting films of the one of said unit pixels located at the periphery of the imaging area.

## 18. (New) The solid-state imaging apparatus according to claim 9,

wherein each of said plurality of light-transmitting films of one of said unit pixels located at the periphery of an imaging area has a line width shorter than a line width of each of said light-transmitting films of one of said unit pixels located near the center of the imaging area and is located at a same relative position in said light-collector as a position of each of said light-

transmitting films of the one of said unit pixels located at the periphery of the imaging area, the imaging area being a plane area on which said unit pixels are formed.